

30V N-Ch Power MOSFET

Feature

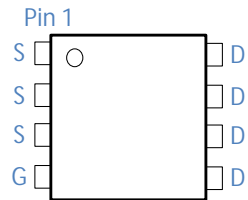
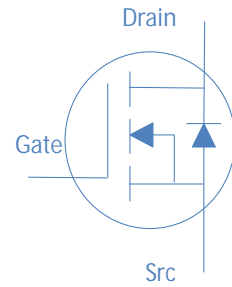
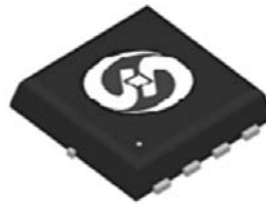
- High Speed Power Switching, Logic Level
- Enhanced Avalanche Ruggedness
- 100% UIS Tested, 100% Rg Tested
- Lead Free, Halogen Free

V_{DS}	30	V
$R_{DS(on), typ}$	$V_{GS}=10V$	15.5 mΩ
I_D (Silicon Limited)	12	A

Application

- Hard Switching and High Speed Circuit
- DC/DC in Telecoms and Industrial

DFN3x3



Part Number	Package	Marking
HTM200N03	DFN3*3	TM200N03

Absolute Maximum Ratings at $T_J=25$ (unless otherwise specified)

Parameter	Symbol	Conditions	Value	Unit
Continuous Drain Current (Silicon Limited)	I_D	$T_C=25$	12	A
		$T_C=100$	9	
Drain to Source Voltage	V_{DS}	-	30	V
Gate to Source Voltage	V_{GS}	-	± 20	V
Pulsed Drain Current	I_{DM}	-	48	A
Avalanche Energy, Single Pulse	E_{AS}	$L=0.1mH, T_C=25$	3.2	mJ
Power Dissipation	P_D	$T_C=25$	21	W
Operating and Storage Temperature	T_J, T_{stg}	-	-55 to 150	

Absolute Maximum Ratings

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-Ambient	$R_{\theta JA}$	50	$^{\circ}W$
Thermal Resistance Junction-Case	$R_{\theta JC}$	6	$^{\circ}W$

Electrical Characteristics at $T_J=25$ (unless otherwise specified)
Static Characteristics

Parameter	Symbol	Conditions	Value			Unit
			min	typ	max	
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	30	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1	1.5	3	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS}=0V, V_{DS}=24V, T_J=25$	-	-	1	μA
		$V_{GS}=0V, V_{DS}=20V, T_J=125$	-	-	25	
Gate to Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Drain to Source on Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=8A$	-	15.5	20	m Ω
		$V_{GS}=4.5V, I_D=6A$	-	25	30	
Transconductance	g_{fs}	$V_{DS}=5V, I_D=8A$	-	16	-	S
Gate Resistance	R_G	$V_{GS}=15mV, V_{DS}=0V, f=1MHz$	-	2.0	-	Ω

Dynamic Characteristics

Input Capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=15V, f=1MHz$	-	520	-	pF
Output Capacitance	C_{oss}		-	88	-	
Reverse Transfer Capacitance	C_{rss}		-	62	-	
Total Gate Charge	$Q_g(10V)$	$V_{DD}=15V, I_D=8A, V_{GS}=10V$	-	11.5	-	nC
	$Q_g(4.5V)$		-	5	-	
Gate to Source Charge	Q_{gs}		-	1.6	-	
Gate to Drain (Miller) Charge	Q_{gd}		-	2.8	-	
Turn on Delay Time	$t_{d(on)}$	$V_{DD}=15V, I_D=1A, V_{GS}=10V, R_G=6\Omega,$	-	9	-	ns
Rise time	t_r		-	12	-	
Turn off Delay Time	$t_{d(off)}$		-	30	-	
Fall Time	t_f		-	15	-	

Reverse Diode Characteristics

Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_F=2.3A$	-		1.2	V
Reverse Recovery Time	t_{rr}	$I_F=2.3A, di_F/dt=100A/\mu s$	-	45	-	ns
Reverse Recovery Charge	Q_{rr}		-	2	-	nC

Fig 1. Typical Output Characteristics

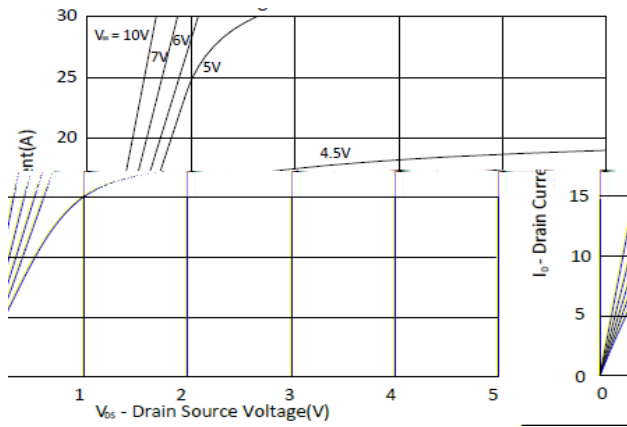


Figure 2. On-Resistance vs. Gate-Source Voltage

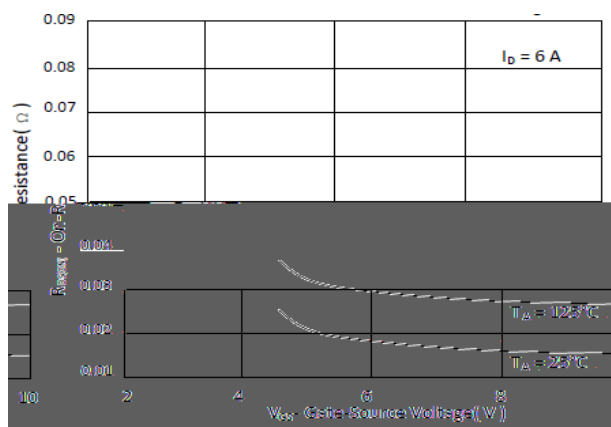


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

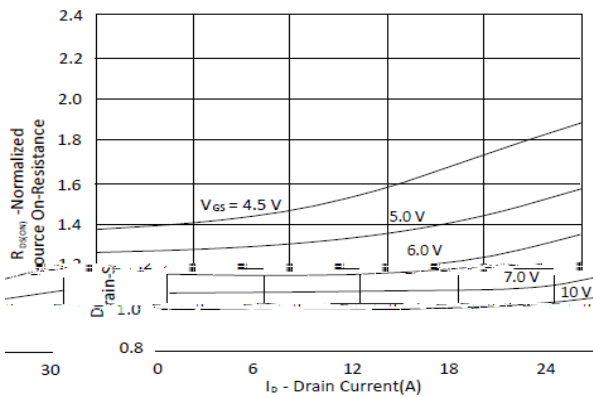


Figure 4. Normalized On-Resistance vs. Junction Temperature

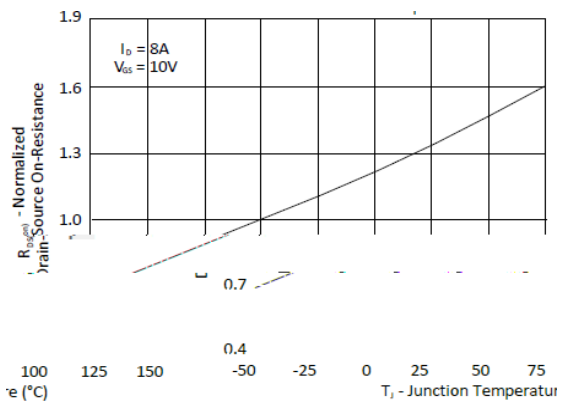


Figure 5. Typical Transfer Characteristics

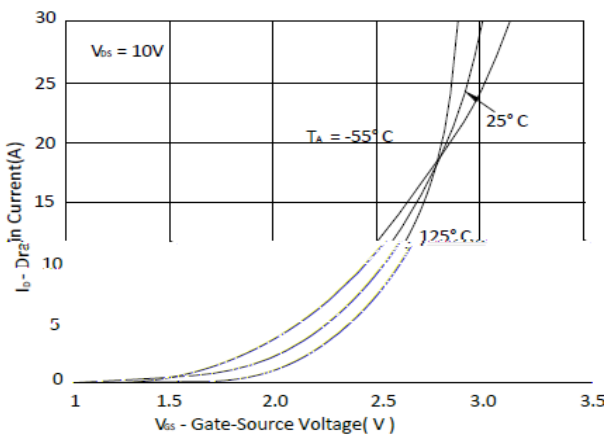


Figure 6. Typical Source-Drain Diode Forward Voltage

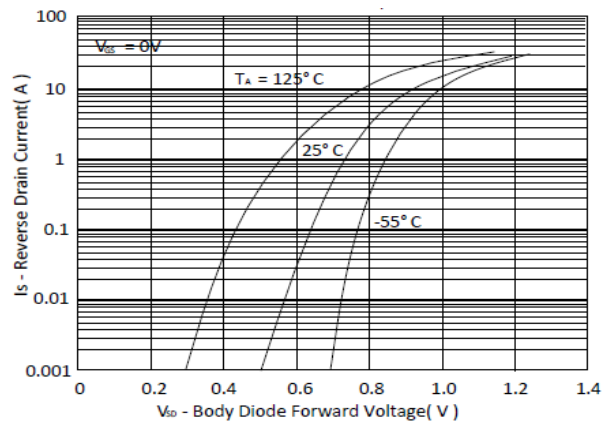


Figure 9. Maximum Safe Operating Area

Figure 10. Single Pulse Maximum Power Dissipation

Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Ambient

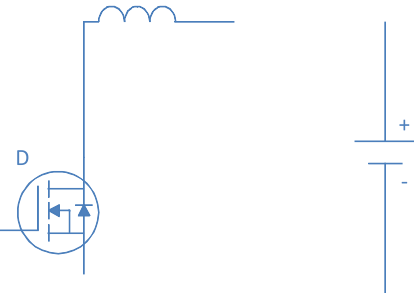
Inductive switching Test

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Gate Charge Test

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Uclamped Inductive Switching (UIS) Test

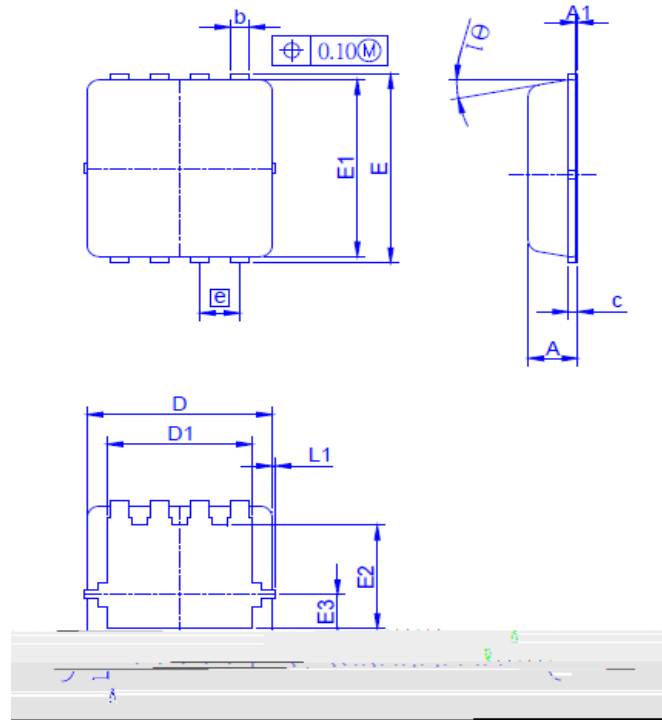
	
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Diode Recovery Test

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Package Outline

DFN3*3, 8leads



Dimension in mm

Dimension	A	A1	b	c	D	D1	E	E1	E2	E3	e	L	L1	$\theta 1$
Min.	0.70	0	0.24	0.10	2.95	2.25	3.15	2.95	1.65			0.30		0°
Typ.	0.80		0.30	0.152	3.00	2.35	3.20	3.00	1.75	0.575	0.65	0.40	0.13	10°
Max.	0.90	0.05	0.37	0.25	3.15	2.45	3.40	3.15	1.96			0.50		12°